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Ourston, D.; Matzner, M.; Stump, W.; Hopkins, B.;

System Sciences, 2003. Proceedings of the 36th Annual Hawaii International Conference on, 6-9 Jan. 2003

Pages:334 - 343

[\[Abstract\]](#) [\[PDF Full-Text \(569 KB\)\]](#) **IEEE CNF**
2 High-performance MIMO receivers based on multi-stage partial para interference cancellation
Claussen, H.; Karimi, H.R.; Mulgrew, B.;

Vehicular Technology Conference, 2003. VTC 2003-Fall. 2003 IEEE 58th, Vol. 1, 6-9 Oct. 2003

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3 Multi-stage interference canceller using adaptive signal processing
Shimizu, S.; Kawakami, E.; Tokuda, K.;

 Vehicular Technology Conference, 1997 IEEE 47th, Volume: 2, 4-7 May 1997
 Pages:1094 - 1098 vol.2

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4 Multi-stage detection scheme for CDMA systems
Rezaaifar, E.; Tho Le-Ngoc;

Electrical and Computer Engineering, 1997. IEEE 1997 Canadian Conference on, Volume: 2, 25-28 May 1997

Pages:474 - 477 vol.2

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5 Performance of the multi-stage detector for a MC-CDMA system in a Rayleigh fading channel

Kalofonos, D.N.; Proakis, J.G.;

Global Telecommunications Conference, 1996. GLOBECOM '96. 'Communications The Key to Global Prosperity', Volume: 3, 18-22 Nov. 1996

Pages:1784 - 1788 vol.3

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6 A structural framework for modeling multi-stage network attacks

Daley, K.; Larson, R.; Dawkins, J.;

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7 Robust face detection at video frame rate based on edge orientation features

Froba, B.; Kublbeck, C.;

Automatic Face and Gesture Recognition, 2002. Proceedings. Fifth IEEE International Conference on, 20-21 May 2002

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8 Application of a genetic algorithm to multi-stage detection in CDMA systems

Ergun, C.; Hacioglu, K.;

Electrotechnical Conference, 1998. MELECON 98., 9th Mediterranean, Volume 2, 18-20 May 1998

Pages:846 - 850 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(420 KB\)\]](#) [IEEE CNF](#)

9 Performance comparison of multi-stage SIC and limited tree-search detection in CDMA

Oyama, T.; Sumei Sun; Sugimoto, H.; Lim, T.J.; Rasmussen, L.K.; Matsumoto Vehicular Technology Conference, 1998. VTC 98. 48th IEEE, Volume: 3, 18-21 May 1998

Pages:1854 - 1858 vol.3

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10 Impact of estimation errors on multiuser detection in CDMA

Rasmussen, L.K.; Sumei Sun; Lim, T.J.; Sugimoto, H.;

Vehicular Technology Conference, 1998. VTC 98. 48th IEEE, Volume: 3, 18-21 May 1998

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